

Thermal Characteristics									
Parameter		Symbol	Тур	Мах	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	P	31	40	°C/W				
Maximum Junction-to-Ambient ^A	Steady-State	$ R_{\theta JA}$	59	75	°C/W				
Maximum Junction-to-Lead ^C	Steady-State	$R_{ ext{ heta}JL}$	16	24	°C/W				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Мах	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V				1	μA
	Zero Gale Voltage Drain Gurrent	T _J =55°C				5	μΛ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ I _D =250µA		1	1.9	3	V
I _{D(ON)}	On state drain current V_{GS} =4.5V, V_{DS} =5V			20			А
R _{DS(ON)}		V _{GS} =10V, I _D =8.5A			20	26	mΩ
	Static Drain-Source On-Resistance		T _J =125°C		29.2	38	
		V _{GS} =4.5V, I _D =5A			31	40	mΩ
g _{FS}	Forward Transconductance V _{DS} =5V, I _D =5A			10	16		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V
ls	Maximum Body-Diode Continuous Current					4.3	А
DYNAMIC	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz		21	680		pF
C _{oss}	Output Capacitance				102		pF
C _{rss}	Reverse Transfer Capacitance				77		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			5		Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	-V _{GS} =10V, V _{DS} =15V, I _D =8.5A			13.84		nC
Q _g (4.5V)	Total Gate Charge				6.74		nC
Q_{gs}	Gate Source Charge				1.84		nC
Q_{gd}	Gate Drain Charge				3.32		nC
t _{D(on)}	Turn-On DelayTime				4.5		ns
t _r	Turn-On Rise Time	V _{GS} =10V, V _{DS} =15V, I	ν _{GS} =10V, V _{DS} =15V, R _L =1.8Ω,		4.2		ns
t _{D(off)}	Turn-Off DelayTime	R _{GEN} =3Ω			20.1		ns
t _f	Turn-Off Fall Time				4.9		ns
t _{rr}	Body Diode Reverse Recovery Time I _F =8.5A, dI/dt=100A/µs			17.2		ns	
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8.5A, dI/dt=100A/μs			8.6		nC

A: The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$. The value in any a given application depends on the user's specific board design. The current rating is based on the t < 10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 0JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.